

7/29/2013



**PRODUCT RELIABILITY REPORT
FOR**

71M6542FT

Maxim Integrated

**14460 Maxim Dr.
Dallas, TX 75244**

Approved by:

**Don Lipps
Manager, Reliability Engineering**

Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Maxim Integrated products:

71M6542FT

In addition, Maxim Integrated's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at <http://www.maximintegrated.com/qa/reliability/monitor>.

Device Description:

A description of this device can be found in the product data sheet. You can find the product data sheet at <http://www.maximintegrated.com/search/parts.mvp>.

Reliability Derating:

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

$$A_fT = \exp((E_a/k) * (1/T_u - 1/T_s)) = t_u/t_s$$

A_fT = Acceleration factor due to Temperature
t_u = Time at use temperature (e.g. 55°C)
t_s = Time at stress temperature (e.g. 125°C)
k = Boltzmann's Constant (8.617 x 10⁻⁵ eV/°K)
T_u = Temperature at Use (°K)
T_s = Temperature at Stress (°K)
E_a = Activation Energy (e.g. 0.7 eV)

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7eV will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

$$A_fV = \exp(B * (V_s - V_u))$$

A_fV = Acceleration factor due to Voltage
V_s = Stress Voltage (e.g. 7.0 volts)
V_u = Maximum Operating Voltage (e.g. 5.5 volts)
B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (C_f).

The failure rate, Fr, is related to the acceleration during life test by:

$$Fr = X / (t_s * A_fV * A_fT * N * 2)$$

X = Chi-Sq statistical upper limit
N = Life test sample size

Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

$$\text{MTTF} = 1/\text{Fr}$$

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAILURE RATE: **MTTF (YRS):** **342667** **FITS:** **0.3**
DEVICE HOURS: **2750486575** **FAILS:** **0**

Only data from Operating Life or similar stresses are used for this calculation.

The parameters used to calculate this failure rate are as follows:

Cf: 60% **Ea: 0.7** **B: 0** **Tu: 25** °C **Vu: 3.6** Volts

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. **Bold** Product Number denotes specific product data.

Device Information:

Process: TSMC 0.25um, Mixed signal, Embedded flash, General Purpose, Double poly Quad metal, 2.5V/3.3V
Passivation: SiO/SiN = 1000nm/700nm
Die Size: 127 x 154
Number of Transistors: 1000000
Interconnect: Aluminum / 0.5% Copper
Gate Oxide Thickness: 70 Å

ESD HBM

DESCRIPTION	DATE	CODE/PRODUCT/LOT#	CONDITION	READPOINT	QTY	FAILS	FA#
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 500 VOLTS	1	PUL'S	3	0
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 1000 VOLTS	1	PUL'S	3	0
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 1500 VOLTS	1	PUL'S	3	0
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 2000 VOLTS	1	PUL'S	3	0
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 2500 VOLTS	1	PUL'S	3	0
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 3000 VOLTS	1	PUL'S	3	0
ESD SENSITIVITY	1320	71M6543FT	Z4133985AC JESD22-A114 HBM 4000 VOLTS	1	PUL'S	3	3
Total:						3	No FA

LATCH-UP

DESCRIPTION	DATE	CODE/PRODUCT/LOT#	CONDITION	READPOINT	QTY	FAILS	FA#
LATCH-UP I	1320	71M6543FT	Z4133985AC JESD78A, I-TEST 25C 100mA		6	0	
LATCH-UP I	1320	71M6543FT	Z4133985AC JESD78A, I-TEST 25C 250mA		6	0	

LATCH-UP V	1320	71M6543FT	Z4133985AC	JESD78A, V-SUPPLY TEST 25C	6	0
Total:					0	

OPERATING LIFE

DESCRIPTION	DATE	CODE/PRODUCT/LOT#	CONDITION	READPOINT	QTY	FAILS	FA#
HIGH TEMP OP LIFE	0222	78M6613	26728	125C, 3.6 VOLTS	1000 HRS	76	0
HIGH TEMP OP LIFE	1026	71M6103	26803	125C, 3.3 VOLTS	500 HRS	200	0
HIGH TEMP OP LIFE	1042	71M6543	QB112428AE	125C, 3.3 VOLTS	500 HRS	100	0
HIGH TEMP OP LIFE	1052	71M6543G	445AN	125C, 3.6 VOLTS	192 HRS	77	0
HIGH TEMP OP LIFE	1118	78M6631	GW110677A	125C, 5.0 VOLTS	1000 HRS	1690	0
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3.5 VOLTS	500 HRS	77	0
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3.6 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3.5 VOLTS	500 HRS	77	0
HIGH TEMP OP LIFE	1131	71M6543	GW112093A	125C, 3.6 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	1132	71M6543	GW112093A	125C, 3.5 VOLTS	500 HRS	77	0
HIGH TEMP OP LIFE	1132	71M6543	GW112093A	125C, 3.6 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	1209	78M6611	QX128420AB	125C, 3.6 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	1209	78M6611	QX128420AC	125C, 3.6 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	1209	78M6611	QX128420AD	125C, 3.6 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	1219	78M6610	ZJ123342BC-	125C, 3.6 VOLTS	192 HRS	80	0
HIGH TEMP OP LIFE	1235	MAX78615	ZJ123499AC	125C, 3.6 VOLTS	192 HRS	80	0
HIGH TEMP OP LIFE	1236	71M6542FT	Z4133579DA	125C, 3.6 VOLTS	192 HRS	80	0
HIGH TEMP OP LIFE	1250	MAX78700	ZJ133523ED-	125C, 3.6 VOLTS	192 HRS	80	0
Total:						0	

FAILURE RATE:	MTTF (YRS):	342667	FITS:	0.3
	DEVICE HOURS:	2750486575	FAILS:	0

71M6542FT & 71M6543FT use the same die and are qualified by \43FT ESD & LU plus \42FT HTOL.